

**Notice of References Cited**

Application/Control No.

10/575,864

Applicant(s)/Patent Under

Reexamination

FRANK ET AL.

Examiner

Cherie M. Woodward

Art Unit

1647

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0151473	10-2002	Braisted et al.	514/9
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	(Schafmeister et al., (J Am Chem Soc. 2000;122:5891-5892).
*	V	Phelan (J Am Chem Soc. 22 Jan 1997;119(3):455-460 ) (cited in Applicants IDS of 5/11/2006).
*	W	Jackson (J Am Chem Soc. 1991. 113:9391-9392) (cited in Applicant's IDS of 5/11/2006).
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.